Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/734,894	ONO ET AL.	
Examiner	Art Unit	
Hai C. Pham	2861	

	SEAR	CHED	
Class	Subclass	Date	Examiner
347	19, 228, 240, 251- 254	12/2/2005	HP
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Class	Subclass	Date	Examiner
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